

**Search Notes**

Application/Control No.

10/685,322

Examiner

Ren L. Yan

Applicant(s)/Patent under  
Reexamination

HIRST ET AL.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
347	102 224		
361	103		
	200		
	201		
101	483		
	484		
399	93		
	94		
372	29.012		
	29.015		
	34		
	36		
above search		1/31/07	RY
updated			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search	1/27/07	RY